Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10541763	BICHOT ET AL.
Examiner	Art Unit
WEI PO KAO	2464

SEARCHED

Class	Subclass	Date	Examiner
370	310,328,329,338,431,445,447,351,389,390,461,462	1/17/08	MC
709	224,263,217,218,249	1/17/08	MC
same as above	same as above	1/21/09	MC
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	2/26/2009	wk
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	10/8/2009	wk
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	2/9/2010	wk
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	8/18/2010	wk
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	2/27/2011	wk

SEARCH NOTES			
Search Notes	Date	Examiner	
East (All DBs) - See Attached	1/17/08	MC	
same as above	1/21/09	MC	
east search	2/26/2009	wk	
plus search	2/26/2009	wk	
class search	2/26/2009	wk	
inventor name search	2/26/2009	wk	
class search	10/8/2009	wk	
east search	10/8/2009	wk	
class search	2/9/2010	wk	
east search	2/9/2010	wk	
class search, east search	8/18/2010	wk	
class search, east search	2/27/2011	wk	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/WEI-PO KAO/ Examiner.Art Unit 2464	